



UNITED STATES PATENT AND TRADEMARK OFFICE

UNITED STATES DEPARTMENT OF COMMERCE
United States Patent and Trademark Office
Address: COMMISSIONER FOR PATENTS
P.O. Box 1450
Alexandria, Virginia 22313-1450
www.uspto.gov

APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/808,838	03/24/2004	John W. Lundstrom		6716

7590
JOHN W. LUNDSTROM
603 CRESTVIEW DR.
GLEN DORA, CA 91741

04/19/2007

EXAMINER

ZHU, JOHN X

ART UNIT	PAPER NUMBER
----------	--------------

2858

MAIL DATE	DELIVERY MODE
-----------	---------------

04/19/2007

PAPER

Please find below and/or attached an Office communication concerning this application or proceeding.

Examiner-Initiated Interview Summary	Application No.	Applicant(s)	
	10/808,838	LUNDSTROM, JOHN W.	
	Examiner	Art Unit	
	John Zhu	2858	

All Participants:

(1) John Zhu.

(2) William Haefliger.

Status of Application: After Allowance

(3) _____

(4) _____

Date of Interview: 9 April 2007

Time: 6:00 pm

Type of Interview:

- ☒ Telephonic
☐ Video Conference
☐ Personal (Copy given to: ☐ Applicant ☐ Applicant's representative)

Exhibit Shown or Demonstrated: ☐ Yes ☒ No

If Yes, provide a brief description:

Part I.

Rejection(s) discussed:

n/a

Claims discussed:

n/a

Prior art documents discussed:

n/a

Part II.
SUBSTANCE OF INTERVIEW DESCRIBING THE GENERAL NATURE OF WHAT WAS DISCUSSED:

Applicant needs to submit an Application Data Sheet in accordance with declaration. Applicant agreed to fax in ADS as soon as possible.

Part III.

- ☒ It is not necessary for applicant to provide a separate record of the substance of the interview, since the interview directly resulted in the allowance of the application. The examiner will provide a written summary of the substance of the interview in the Notice of Allowability.
☐ It is not necessary for applicant to provide a separate record of the substance of the interview, since the interview did not result in resolution of all issues. A brief summary by the examiner appears in Part II above.

Anjan Deb

**ANJAN DEB
PRIMARY EXAMINER**

[Signature]

(Examiner/SPE Signature)

(Applicant/Applicant's Representative Signature – if appropriate)